

# MLCC APPLICATION GUIDE



MLCC application guide

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Operating Condition	1) The capacitor must be stored in an ambient temperature between 5 ~ 40°C with a relative humidity
	of 20 ~ 70%. The products should be used within 12 months upon receipt.
	2) The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulfate, Chlorine and Ammonia and sulfur.
	3) Avoid storing in direct sunlight and falling of dew.
	4) Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.
	5) Others
	<ul> <li>5-1. Under Operation of Equipment</li> <li>5-1-1. Do not touch a capacitor directly with bare hands during operation in order to avoid the danger of an electric shock.</li> <li>5-1-2. Do not allow the terminals of a capacitor to come in contact with any conductive objects (opert aircuit)</li> </ul>
	<ul> <li>(short-circuit).</li> <li>Do not expose a capacitor to a conductive liquid, inducing any acid or alkali solutions.</li> <li>5-1-3. Confirm the environment in which the equipment will operate is under the specified conditions.</li> <li>Do not use the equipment under the following environments.</li> <li>(1) Being spattered with water or oil.</li> </ul>
	<ul> <li>(2) Being exposed to direct sunlight.</li> <li>(3) Being exposed to ozone, ultraviolet rays, or radiation.</li> <li>(4) Being exposed to toxic gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)</li> <li>(5) Any vibrations or mechanical shocks exceeding the specified limits.</li> <li>(6) Moisture condensing environments.</li> </ul>
	5-1-4. Use damp proof countermeasures if using under any conditions that can cause condensation.
	<ul><li>5-2. Others</li><li>5-2-1. In an Emergency</li><li>(1) If the equipment should generate smoke, fire, or smell, immediately turn off or unplug the</li></ul>
	equipment. If the equipment is not turned off or unplugged, the hazards may be worsened by supplying continuous power.
	(2) In this type of situation, do not allow face and hands to come in contact with the capacitor or burns may be caused by the capacitor's high temperature.
	5-2-2. Disposal of waste When capacitors are disposed of, they must be burned or buried by an industrial waste vendor with the appropriate licenses.
	<ul> <li>5-2-3. Circuit Design         <ul> <li>(1) Addition of Fail Safe Function</li> <li>Capacitors that are cracked by dropping or bending of the board may cause deterioration of the insulation registrance, and regult is a short</li> </ul> </li> </ul>
	<ul> <li>insulation resistance, and result in a short.</li> <li>If the circuit being used may cause an electrical shock, smoke or fire when a capacitor is shorted, be sure to install fail-safe functions, such as a fuse, to prevent secondary accidents.</li> <li>(2) This series are not safety standard certified products.</li> </ul>
	5-2-4. Remarks Failure to follow the cautions may result, worst case, in a short circuit and smoking when the product is used.
	The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions. Select optimum conditions for operation as they determine the reliability of the product after
	assembly. The data herein are given in typical values, not guaranteed ratings.



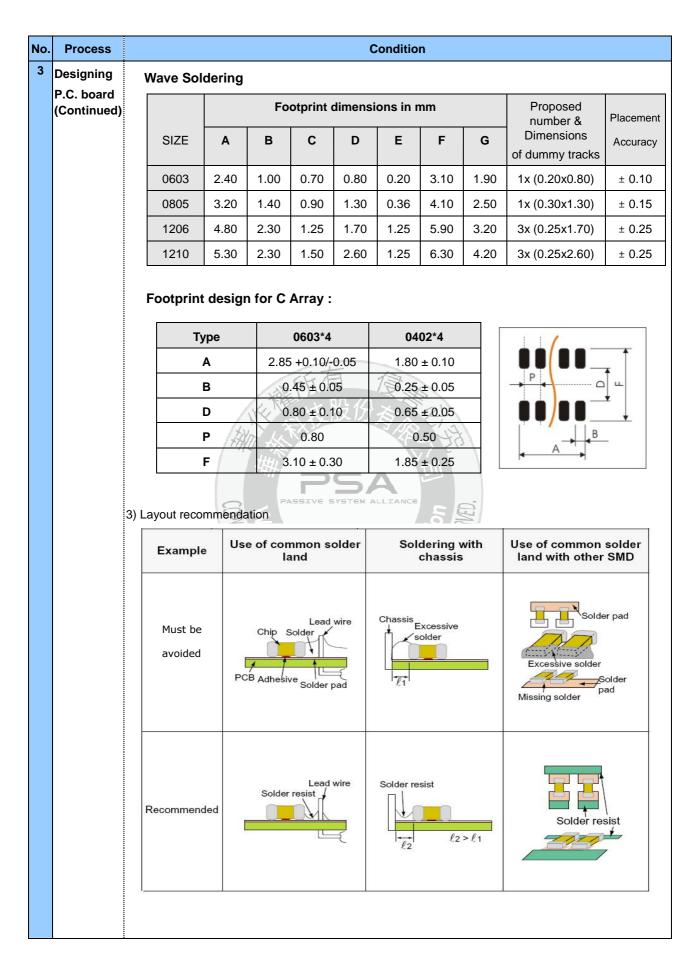
No.	Process								
2	Circuit design ! Caution	2-1 Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.							
	! Caution	1) Do not us	e capacitor abov	e the maximum allo	wable operating	temperature.			
		(Due to d around its Please de self-heati	lielectric loss, ca s SRF, the heat esign the circuit	ding self-heating shi pacitor will heat itse might be so extreme so that the maximur he maximum allowa below $20^{\circ}$	If when AC is app that it may dam n temperature of	olied. Especially at age itself or the su the capacitor inclu	high frequencies rrounding area.		
		2-2 Operatin	g voltage						
		When A oversho AC or P When th may be	C and DC are su oting, Vp-p must ulse with oversho ne voltage is star generated for a t	the terminals should per imposed, the per be below the rated poting, Vp-p must be ted to apply to the c rransit period becau- ltage containing the	eak must be belo voltage. e below the rated ircuit or it is stopp se of resonance	w the rated voltage  l voltage.  ped applying, the ir or switching. Be su	(1)&(2) (3),(4)&(5) regular voltage		
		Voltage	(1) DC voltage	(2) DC+AC voltage	(3) AC voltage	(4) Pulse voltage (A)	(5) Pulse voltage (B)		
		Positional Measurement (Rated voltage)	<b>V</b> <sub>0-P</sub>		V <sub>P-P</sub> O				
		<ul> <li>2) Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitor may be reduced.</li> <li>3) Voltage derating will greatly reduce the failure rate. Since the failure rate follows the 3 power law of voltage, the failure rate used under Uw with UR rated product will be lowered as (Uw/UR)<sup>3</sup>.</li> </ul>							



No.	Process	Condition									
3	Designing	The amount of solder at the terminations has a direct effect on the reliability of the capacitor.									
	<ul> <li>P.C. board <ol> <li>The greater the amount of solder, the higher the stress on the chip capacitor, and the it will break. When designing a P.C. board, determine the shape and size of the sold proper amount of solder on the terminations.</li> <li>Avoid using common solder pads for multiple terminations and provide individual sold each termination.</li> </ol> See the following table for recommended pad dimensions.</li></ul>										bads to have
									So	ccupied area	-
								<u>↓</u>		lderpaste patte	
				•	B					lder resist patterr	
A A							acks or Dummy tr or wave soldering				
			•		F					J	2,7
		Reflow S		4	7						
		Renow a	loideili	<u>-HSH-A</u>							
				Fo	otprint	dimensi	ons in r	nm		Processing	Placement
		SIZE	Α	В	С	D	Е	F	G	remarks	Accuracy
		01005	0.45	0.20	0.15	0.21	N/A	0.65	0.38		± 0.05
		0201	0.65	0.23	0.21	0.30	N/A	0.90	0.60		± 0.05
		0402	1.50	0.40	0.50	0.50	0.10	1.75	0.95		± 0.15
		0508	2.50	0.50	1.00	2.00	0.15	2.90	2.40		± 0.20
		0505	3.43	0.94	1.42	2.11	N/A	N/A	N/A		± 0.25
		0603	2.30	0.70	0.80	0.80	0.20	2.55	1.40		± 0.25
		0612	2.80	0.80	1.00	3.20	0.20	3.08	3.85		± 0.25
		0805	2.80	1.00	0.90	1.30	0.40	3.05	1.85	Doflaw as hat	± 0.25
		1111	4.62	2.01	1.42	3.45	N/A	N/A	N/A	Reflow or hot plate soldering	± 0.25
		1206	4.00	2.20	0.90	1.60	1.60	4.25	2.25		± 0.25
		1210	4.00	2.20	0.90	2.50	1.60	4.25	3.15		± 0.25
		1808	5.40	3.30	1.05	2.30	2.70	5.80	2.90		± 0.25
		1825	5.30	3.50	0.90	6.50	N/A	N/A	N/A		± 0.30
		1812	5.30	3.50	0.90	3.80	3.00	5.55	4.05		± 0.25
		2211	7.00	4.30	1.35	3.70	N/A	7.60	4.10		± 0.30
			7.00	4.30	1.35	5.00	N/A	7.60	5.50		± 0.30
		2220	7.00	1.00	1.00	0.00					

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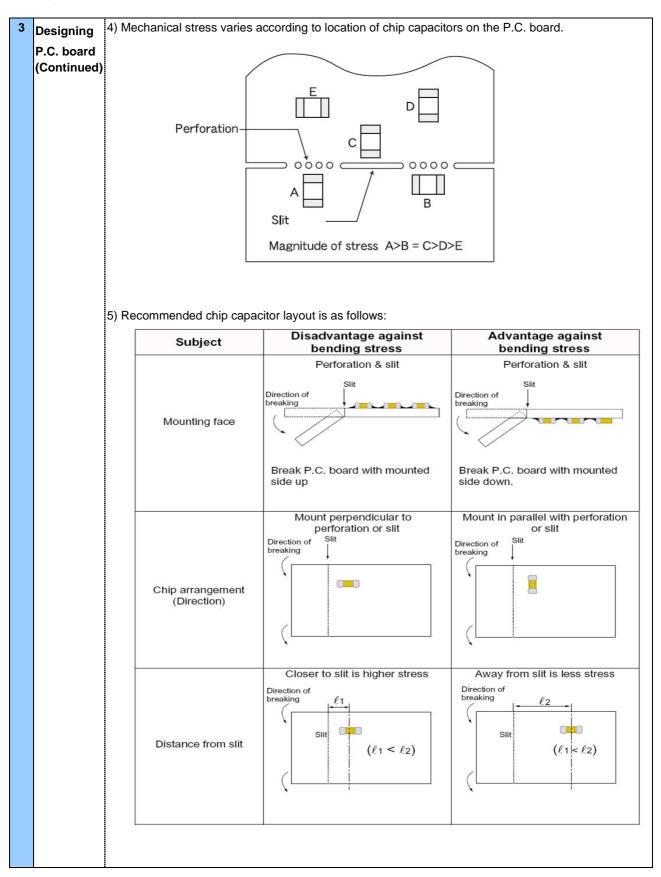
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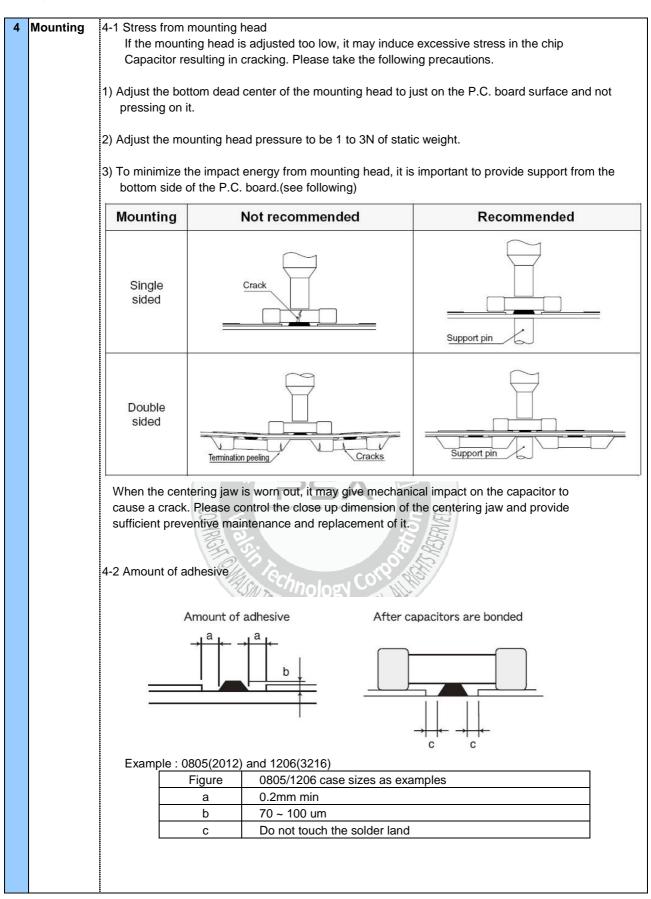
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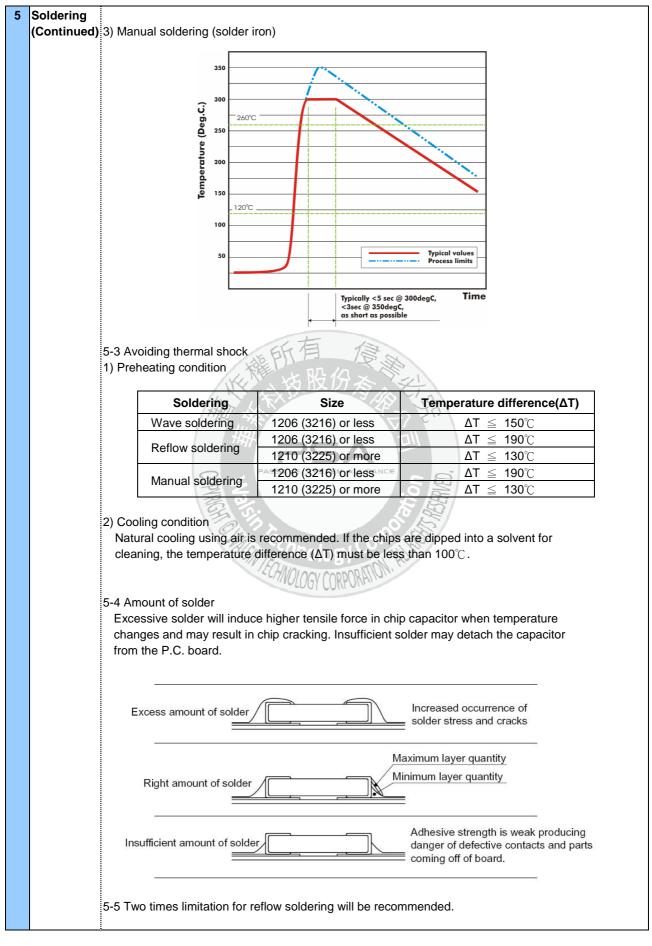






5 Soldering 5-1 Flux selection Although highly-activated flux gives better solderability, substances which increase activity may also degrade the insulation of the chip capacitors. To avoid such degradation, the following is recommended. 1) It is recommended to use a mildly activated rosin flux (less than 0.1 wt% chlorine). Strong flux is not recommended. 2) Excessive flux must be avoided. Please provide proper amount of flux. 3) When water-soluble flux is used, enough washing is necessary. 5-2 Recommended soldering profile by various methods 1) Recommended reflow soldering profile for SMT process with SnAgCu series solder paste 260 245 max. ramp up rate = 3°C/s max. ramp down rate = 6°C/s 21 200 Temp. (DegC) 150 For SnAgCu series solder paste 25 Time 30 sec min. 60~120 sec 60~150 sec 480 sec max, to Peak 2) Wave soldering profile Recommended wave soldering **Temperature (Deg.C.)** profile for SMT process with SnAgCu series solder. 150 °C/sec ma # Wave soldering is recommended Natural Cooling only for the following case sizes: 0603(1608); 0805(2012) 120°C &1206(3216) thickness< 1mm 100 50 Time 3~5 sec Over 60 sec <100 sec





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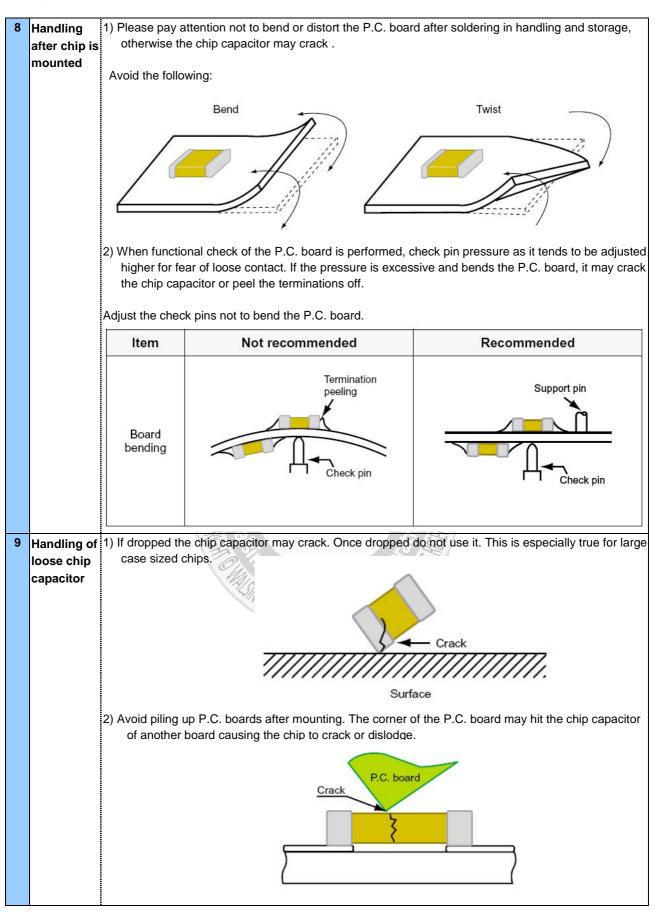


		<ul> <li>5-6 Solder repair by solder</li> <li>1) Selection of the solderin Tip temperature of sold temperature may be fa are recommended.)</li> <li>Size</li> <li>1206 (3216) or less</li> <li>1210 (3225) or more</li> <li>2) Direct contact of the sol not make contact direct</li> </ul>	ng iron tip der iron varies by ster, but the heat Temp. (°C) <u>350°C Max</u> 280°C Max	shock may crack Preheating Temp. (℃) >150℃ >150℃ eramic dielectric	the chip capacitor. Temperature difference( $\Delta T$ ) $\Delta T \leq 190^{\circ}C$ $\Delta T \leq 130^{\circ}C$	(Following condi Atmosphere Room air Room air				
		Tip temperature of solo temperature may be fa are recommended.) Size 1206 (3216) or less 1210 (3225) or more 2) Direct contact of the sol	der iron varies by ster, but the heat Temp. (°C) <u>350°C Max</u> 280°C Max dering iron with c tly with the ceram	shock may crack Preheating Temp. (℃) >150℃ >150℃ eramic dielectric	the chip capacitor. Temperature difference( $\Delta T$ ) $\Delta T \leq 190^{\circ}C$ $\Delta T \leq 130^{\circ}C$	(Following condi Atmosphere Room air Room air				
		are recommended.) Size 1206 (3216) or less 1210 (3225) or more 2) Direct contact of the sol	Temp. (℃) 350℃ Max 280℃ Max Idering iron with c tly with the ceram	Preheating Temp. (℃) >150℃ >150℃ eramic dielectric	$\begin{array}{r l} Temperature \\ difference(\Delta T) \\ \hline \Delta T &\leq 190^{\circ} C \\ \hline \Delta T &\leq 130^{\circ} C \end{array}$	Atmosphere Room air Room air				
		1206 (3216) or less 1210 (3225) or more 2) Direct contact of the sol	350°C Max 280°C Max Idering iron with c tly with the ceram	Temp. (°C)           >150°C           >150°C           eramic dielectric	$\begin{array}{c c} \text{difference}(\Delta T) \\ \hline \Delta T \ \leq \ 190^\circ \mathbb{C} \\ \hline \Delta T \ \leq \ 130^\circ \mathbb{C} \end{array}$	Room air Room air	g. Do			
		1210 (3225) or more 2) Direct contact of the sol	280℃ Max dering iron with c tly with the ceram	>150°C eramic dielectric	$\Delta T \leq 130^{\circ}C$	Room air	g. Do			
		2) Direct contact of the sol	dering iron with c	eramic dielectric			] g. Do			
			tly with the ceram		of chip capacitor ma	ay cause crackin	g. Do			
			Hand coldaria		/ /					
				a method						
					$\mathcal{A}$					
				\\						
6 CI		<ol> <li>If an unsuitable cleaning fluid is used, flux residue or some foreign article may stick to chip capacitor surface causing deteriorated performance, especially insulation resistance.</li> <li>If the cleaning condition is not suitable, it may damage the chip capacitor.</li> <li>Insufficient washing         <ol> <li>Lead wire and terminal electrodes may corrode due to Halogen in the flux.</li> <li>Halogen in the flux may adhere on the surface of capacitor, and lower the insulation resistance.</li> <li>Water soluble flux has higher tendency to have the above mentioned problems (1) and (2).</li> </ol> </li> <li>Excessive washing         <ul> <li>When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, use the following recommended condition.</li> <li>Power : 20W/I max.</li> <li>Frequency : 40kHz max.</li> <li>Washing time : 5 minutes max.</li> </ul> </li> </ol>								
		2-3) If the cleaning fluid is contaminated, the density of Halogen increases, and it may bring the sam result as insufficient cleaning.								
		3) Selection of cleaning fluid In general, washing is not necessary if rosin-based flux is used. When using active flux, suitable								
		In general, washing is n cleaning fluids are wate	-		-		ie			
		4) Precautions								
	After the reflow process, wait at least 5 minutes before proceeding with the cleaning									
7 Co	oating and	1) When the P.C. board is	coated, verify the	e quality influence	e on the product.					
the	olding of ne P.C. oard	<ol> <li>Please verify that there may damage the chip of</li> </ol>		composing or read	ction gas emission d	luring curing whi	ch			
		3) Please verify the curing	temperature.							

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10	Transporta-	1) The performance of a capacitor may be affected by the conditions during transportation.
	tion	<ul> <li>1-1) The capacitors shall be protected against excessive temperature, humidity and mechanical force during transportation.</li> <li>(1) Climatic condition <ul> <li>low air temperature: -40°C</li> <li>change of temperature air/air: -25°C/+25°C</li> <li>low air pressure: 30 kPa</li> <li>change of air pressure: 6 kPa/min.</li> <li>(2) Mechanical condition</li> <li>Transportation shall be done in such a way that the boxes are not deformed and forces are not directly passed on to the inner packaging.</li> </ul> </li> <li>1-2) Do not apply excessive vibration, shock, and pressure to the capacitor. <ul> <li>(1) When excessive mechanical shock or pressure is applied to a capacitor, chipping or cracking may occur in the ceramic body of the capacitor.</li> <li>(2) When a sharp edge of an air driver, a soldering iron, tweezers, a chassis, etc. impacts strongly on the surface of capacitor, the capacitor may crack and short-circuit.</li> </ul> </li> </ul>
		1-3) Do not use a capacitor to which excessive shock was applied by dropping, etc. The capacitor dropped accidentally during processing may be damaged.
11	Others	1) Effect of low air pressure
		As the atmospheric pressure drops, the risk of a flashover between capacitor terminations increases. Heat transfer can be affected by high altitude operation. Heat generated on the lead terminations cannot be dissipated properly and can result in overheating and eventual failure.



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